Notice of References Cited

Application/Control No.

Applicant(s)/Patent Under Reexamination BAKER ET AL.

Examiner

Peter C. English

Applicant(s)/Patent Under Reexamination BAKER ET AL.

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,059,311	05-2000	Wipasuramonton et al.	280/743.1
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0485599 A1	05-1992	EPO	KOKAGUCHI et al.	B60R 21/16
	0	JP 01122751 A	05-1989	Japan	YONEDA et al.	B60R 21/16
	Р	JP 06016099 A	01-1994	Japan	TAKAHASHI et al.	B60R 21/16
	Q	JP 09226498 A	09-1997	Japan	IINO et al.	B60R 21/20
	R					
	s					
	т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	>	
	w	
	×	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.